Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/619,044	MEYER ET AL.	
Examiner	Art Unit	
C. SAYALA	1761	

SEARCHED				
Class	Subclass	Date	Examiner	
426	1	5/15/2006	cs	
43	57.1			
69	30			
		<u>-</u>		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	
<u> </u>				

SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
Search transcripts attached for USPAT, USPGPUBS, EPO, JPO, DERWENT, USOCR. Google searched	5/15/2006	cs
	:	